

FEATURES

- *Guaranteed* $25\mu V$ max. Offset Voltage
- *Guaranteed* $0.6\mu V/\text{ }^{\circ}\text{C}$ max. Offset Voltage Drift with Temperature
- *Excellent* $1.0\mu V/\text{Month}$ max. Long Term Stability
- *Guaranteed* $0.6\mu V_{\text{p-p}}$ max. Noise
- *Guaranteed* 2.0nA max. Input Bias Current

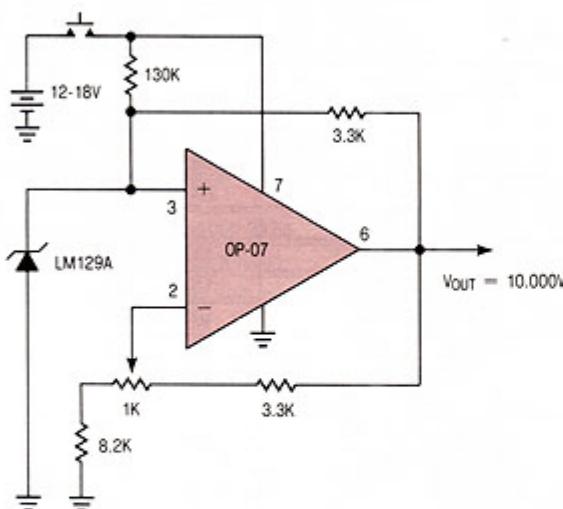
APPLICATIONS

- Thermocouple Amplifiers
- Strain Gauge Amplifiers
- Low Level Signal Processing
- Medical Instrumentation

DESCRIPTION

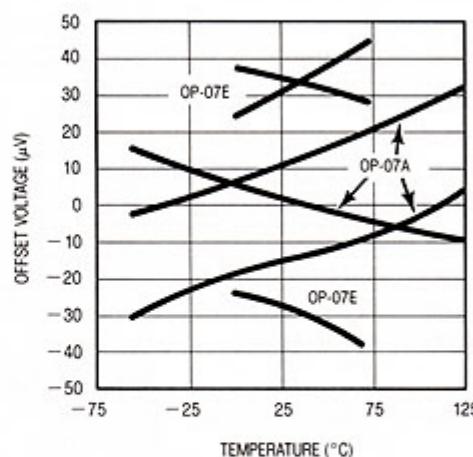
The OP-07 offers excellent performance in applications requiring low offset voltage, low drift with time and temperature and very low noise. Linear's OP-07 is interchangeable with many of the precision op-amp device types. The OP-07 also offers a wide input voltage range, high common mode rejection and low input bias current. These features result in optimum performance for small signal level and low frequency applications. Use of advanced design, processing and testing techniques make Linear's OP-07 a superior choice over similar products. A buffered reference application is shown below. For single op amp applications requiring higher performance, see the LT1001 and for matched dual precision applications see the LT1002.

Precision Buffered Single Supply Reference



The OP-07 contributes less than 5% of the total drift with temperature, noise and long term drift of the reference application.

Offset Voltage Drift With Temperature
Of Representative Units



ELECTRICAL CHARACTERISTICS $V_S = \pm 15V$, $0^\circ C \leq T_A \leq 70^\circ C$, unless otherwise noted.

SYMBOL	PARAMETER	CONDITIONS	OP-07E			OP-07C			UNITS
			MIN	TYP	MAX	MIN	TYP	MAX	
V_{OS}	Input Offset Voltage		●	45	130	85	250	250	μV
$\frac{\Delta V_{OS}}{\Delta T_{Temp}}$	Average Input Offset Voltage Drift Without External Trim With External Trim	Null Pot = $20k\Omega$ (Note 2)	●	0.3 0.3	1.3 1.3	0.5 0.4	1.8 1.6	1.8 1.6	$\mu V/^\circ C$
I_{OS}	Input Offset Current		●	0.9	5.3	1.6	8.0	8.0	nA
$\frac{\Delta I_{OS}}{\Delta T_{Temp}}$	Average Input Offset Current Drift	(Note 2)	●	8	35	12	50	50	pA/°C
I_B	Input Bias Current		●	± 1.5	± 5.5	± 2.2	± 9.0	9.0	nA
$\frac{\Delta I_B}{\Delta T_{Temp}}$	Average Input Bias Current Drift	(Note 2)	●	13	35	18	50	50	pA/°C
	Input Voltage Range		●	± 13.0	± 13.5	± 13.0	± 13.5	13.5	V
CMRR	Common Mode Rejection Ratio	$V_{CM} = \pm 13V$	●	103	123	97	120	120	dB
PSRR	Power Supply Rejection Ratio	$V_S = \pm 3V$ to $\pm 18V$	●	90	104	86	100	100	dB
A_{VOL}	Large Signal Voltage Gain	$R_L \geq 2k\Omega$, $V_o = \pm 10V$	●	180	450	100	400	400	V/mV
V_{OUT}	Output Voltage Swing	$R_L \geq 2k\Omega$	●	± 12.0	± 12.6	± 11.0	± 12.6	12.6	V

The ● denotes the specifications which apply over full operating temperature range.

For MIL-STD components, please refer to LTC 883C data sheet for test listing and parameters.

Note 1: Offset voltage for the OP-07A is measured 60 seconds after power is applied. All other grades are measured with high speed test equipment, approximately 1 second after power is applied.

Note 2: This parameter is tested on a sample basis only.

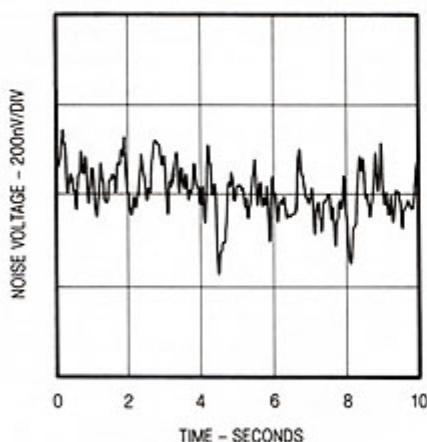
Note 3: Long term Input Offset Voltage Stability refers to the averaged trend line of V_{OS} versus Time over extended periods after the first 30 days of operation. Excluding the initial hour of operation, changes in V_{OS} during the first 30 operating days are typically $2.5\mu V$.

Note 4: This parameter is guaranteed by design.

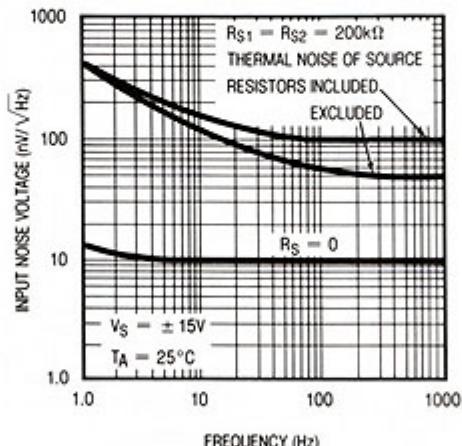
Note 5: The OP-07D is available by special request.

TYPICAL PERFORMANCE CHARACTERISTICS

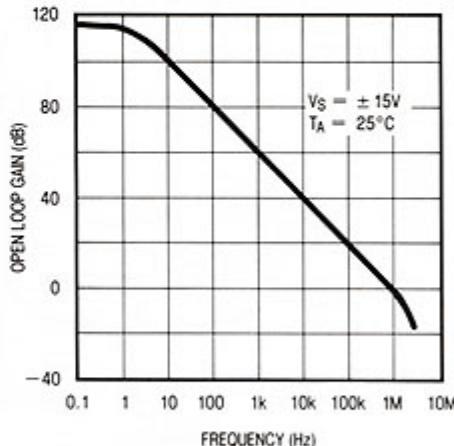
**Low Frequency Noise
(Closed Loop Gain = 25,000)**



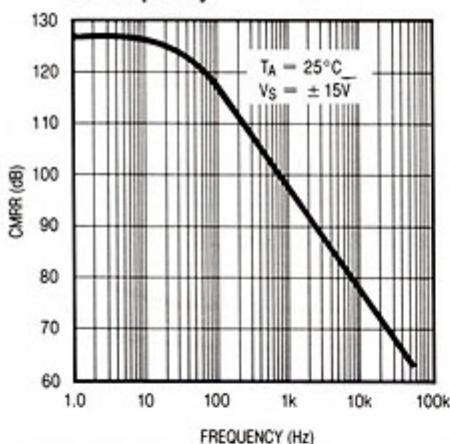
**Total Input Noise Voltage
vs Frequency**



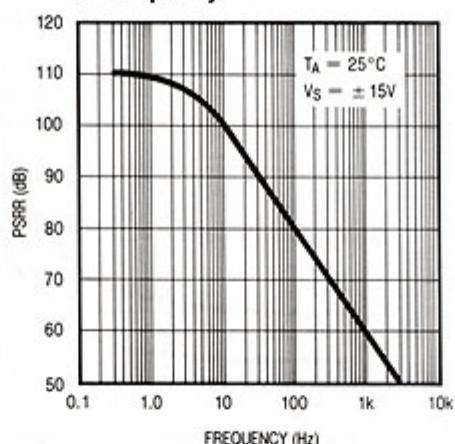
**Open-Loop
Frequency Response**



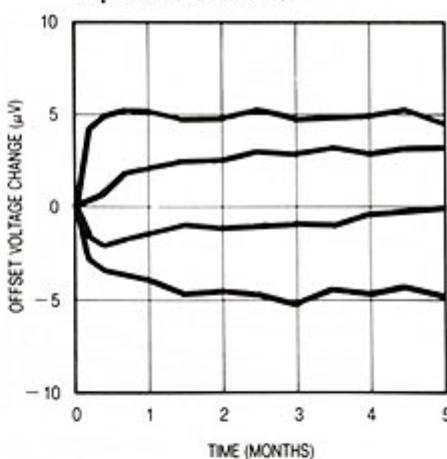
**Common Mode Rejection Ratio
vs Frequency**



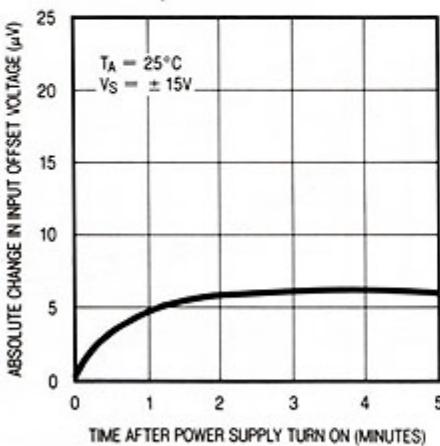
**Power Supply Rejection Ratio
vs Frequency**



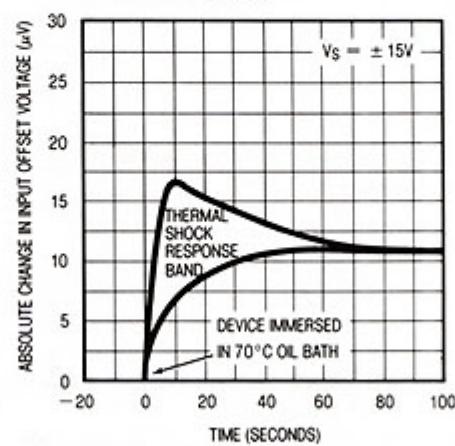
**Long Term Stability of Four
Representative Units**



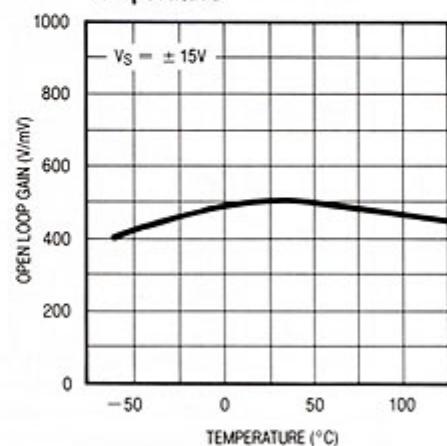
Warm-Up Drift



**Offset Voltage Change Due
to Thermal Shock**

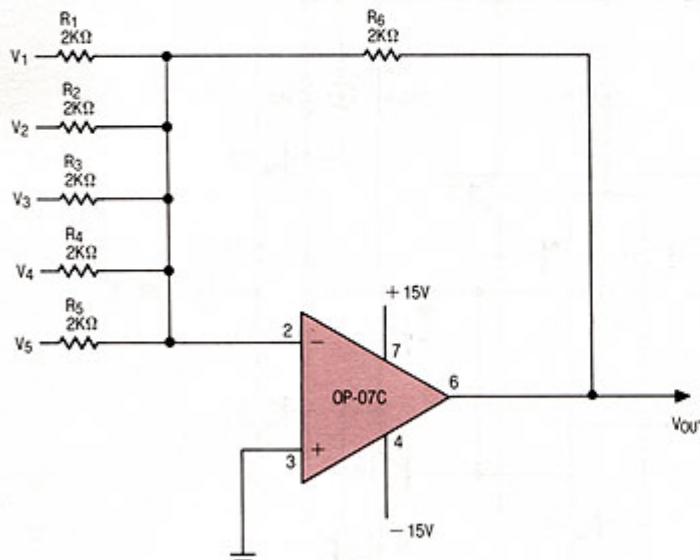


**Open-Loop Gain vs
Temperature**

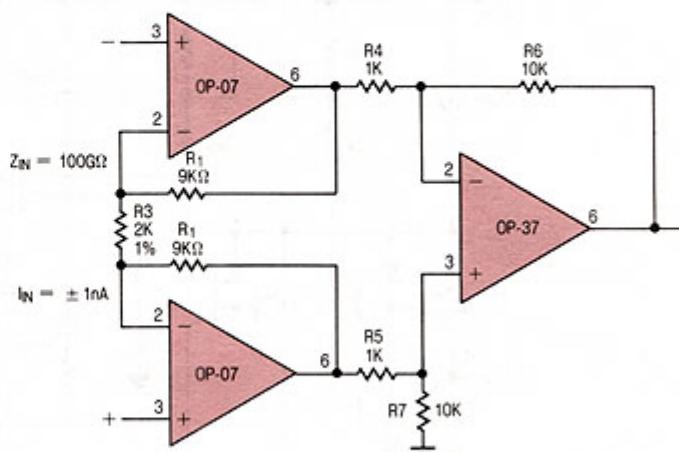


TYPICAL APPLICATIONS

Precision Summing Amplifier



Instrumentation Amplifier

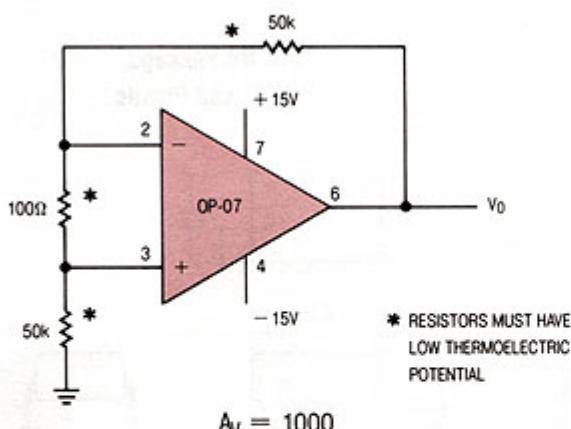


$$A_V = \frac{R_6}{R_4} \left(\frac{2R_1}{R_3} + 1 \right)$$

$$A_V = 100$$

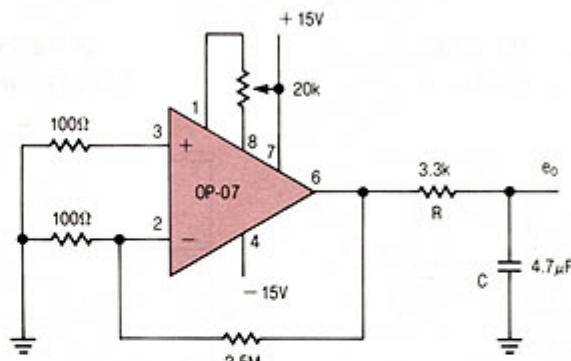
TEST CIRCUIT DIAGRAMS

Offset Voltage Test Circuit †



$$A_V = 1000$$

Offset Nulling and Low Frequency Noise Test Circuit



NOTES:

1) RC APPROXIMATELY 10Hz FILTER

2) OBSERVE OUTPUT FOR 10 SECONDS

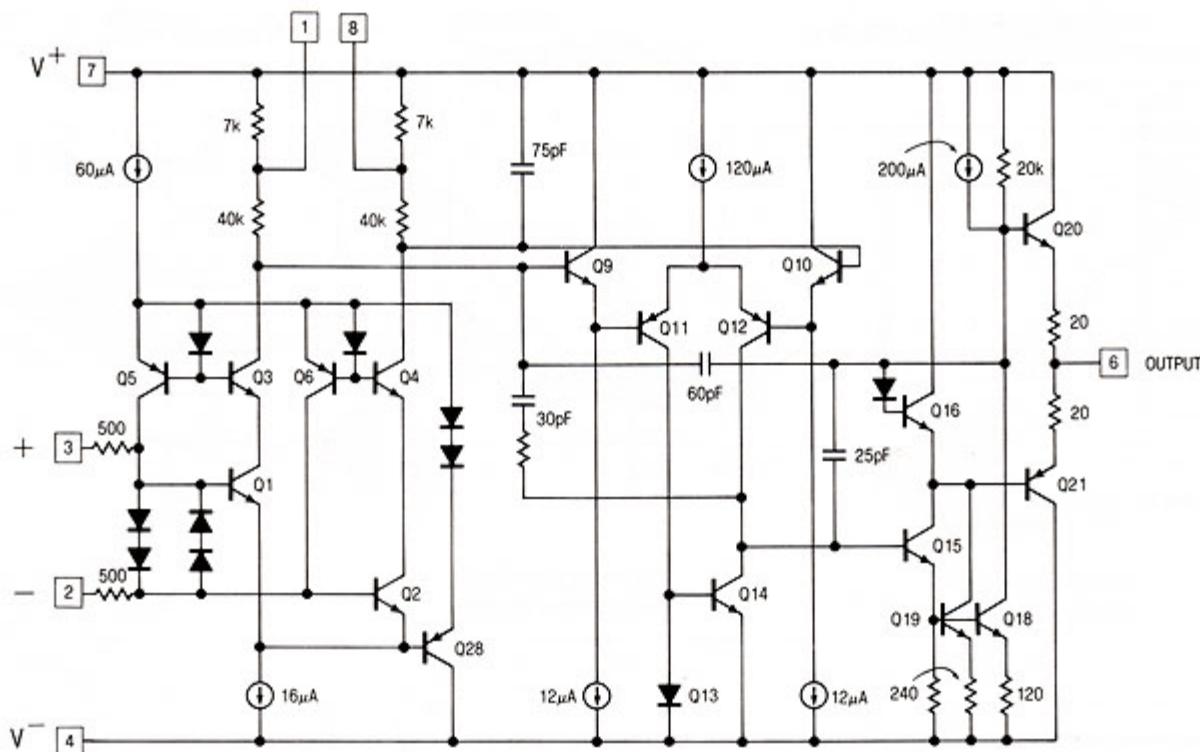
$$A_V = 25000$$

Application Tip:

When the OP-07 is used as a replacement in 725, 108/108A, 308/308A applications, removal of external compensation is optional. For conventionally nulled 741 type applications, external trimming should be removed. Care should be taken to avoid thermocouple voltages caused by temperature variations between the input terminals or dissimilar metals.

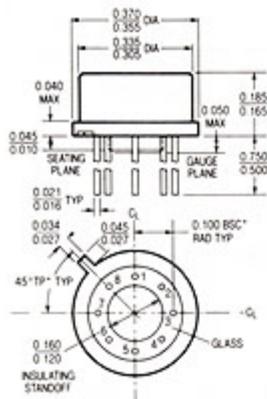
† This circuit is also used as the burn-in configuration with supply voltages changed to ± 20 Volts.

SCHEMATIC DIAGRAM

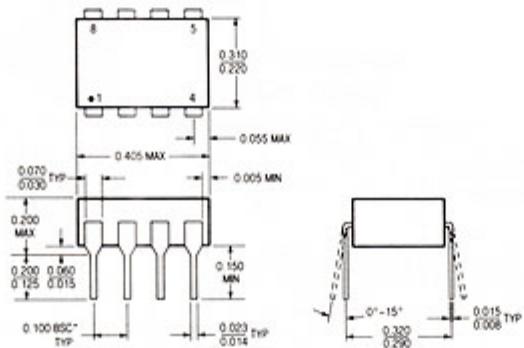


PACKAGE DESCRIPTION

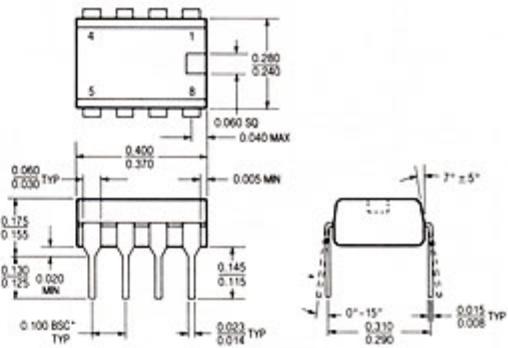
H Package
Metal Can



J8 Package
8 Lead Hermetic Dip



N8 Package
8 Lead Plastic



NOTE: DIMENSIONS IN INCHES

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*LEADS WITHIN 0.007 OF TRUE POSITION (TP) AT GAUGE PLANE

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T _j max	θ _{ja}	θ _{jc}
150°C	150°C/W	45°C/W

T _j max	θ _{ja}
150°C	100°C/W

T _j max	θ _{ja}
100°C	130°C/W